

Search Notes

Application/Control No.

10/021,294

Examiner

Leigh C. Maier

Applicant(s)/Patent under
Reexamination

PUN ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
search	updated		
from	3/5/06	7/6/2006	LCM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
424	280.1 489	7/6/06	LCM
	497 499		
435	486 6,69.1		
	72,455 458		
514	44,54		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-Search updated in EAST	7/6/2006	LCM